## **TEST SETUP PHOTOGRAPHS** 15.

FCC ID: ZNFVS425		HAC (T-COIL) TEST REPORT	🚯 LG	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Dana 70 of 74
0Y1601110077-R1.ZNF	01/21/2015 - 01/25/2015	Portable Handset		Page 72 of 74
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12/9/2015



Figure 15-1 Test Setup for Wireless Device

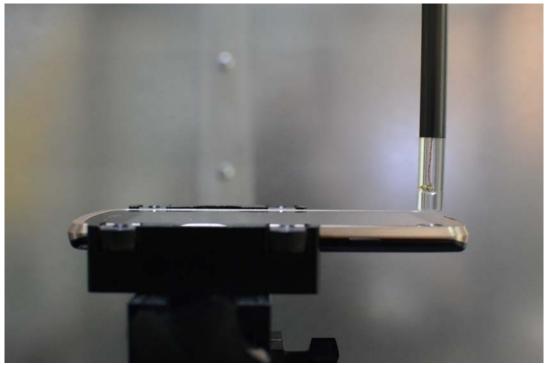


Figure 15-2 Test Setup for Wireless Device

FCC ID: ZNFVS425		HAC (T-COIL) TEST REPORT	قا 🚯	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 73 of 74
0Y1601110077-R1.ZNF	01/21/2015 - 01/25/2015	Portable Handset		
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REV 3.1.M 12/9/2015

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Figure 15-3 T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

FCC ID: ZNFVS425		HAC (T-COIL) TEST REPORT	ور 🚯	Reviewed by: Quality Manager
Filename:	Test Dates:	EUT Type:		Page 74 of 74
0Y1601110077-R1.ZNF	01/21/2015 - 01/25/2015	Portable Handset		
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